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| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>10578102 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>CHOI ET AL. |
|  | <b>Examiner</b><br><br>MARCOS BATISTA          | <b>Art Unit</b><br><br>2617                                       |

| SEARCHED |          |           |          |
|----------|----------|-----------|----------|
| Class    | Subclass | Date      | Examiner |
| 370      | 341      | 4/28/2008 | mb       |
| 370      | 437      | 4/28/2008 | mb       |

| SEARCH NOTES                          |            |          |
|---------------------------------------|------------|----------|
| Search Notes                          | Date       | Examiner |
| Consulted with Rafael Perez Gutierrez | 4/28/2008  |          |
| Consulted with TA - Yogesh Aggarwal   | 4/28/2008  | mb       |
| Consulted with Lun-YI Lao             | 4/28/2008  | mb       |
| East Search                           | 4/28/2008  | mb       |
| Inventor's Name Seach                 | 4/28/2008  | mb       |
| Sefcheck, Gregory B.                  | 11/7/2008  | mb       |
| Consulted with Rafael Perez Gutierrez | 11/18/2008 | mb       |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |

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